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PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

1	APPL NUM 10006633	FILING DATE 12/05/2001	CLASS 430	SUBCLASS	路	W	EXAMINER PLKE			
	**APPLICANTS: Kong Keun; Park Gyu; Jung Jae; Shin Ki;									
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	** FOREIGN APPLICATIONS VERIFIED:									
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	Foreign priority claimed ☐ yes ☐ no 35 USC 119 conditions met ☐ yes ☐ no					ATTORNEY DOCKET NO				
	Verified and Acknowledged Examiners's initials 7 TITLE: Pattern width slimming-inhibiting method of photoresist pattern using photoresist composes.									
	Containing thermal acid generator U.S.DEPT. OF COMM./PAT. & TMPTO-43SL.									
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		Assistant Examiner	Total Claims Print Claim for O.G			
ISS	UE FEE		DRAWING ***			
Amount Due	Date Paid		Shoots Drwg. Figs.Drwg. Print Fig.			
	1	Primary Examiner				
TER	RMINAL	PREPARED FOR ISSUE	Application Examiner			
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